Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	Applicant(s)/Patent under Reexamination	
10/630,634	CAMPBELL, STEPHEN A.		
Examiner	Art Unit		
Stanbar I Kristiit	1745		

SEARCHED					
Class	Subclass	Date	Examiner		
502	104,215, <b>*</b> 216,219,22 <b>0</b> , 222	12/7/2005	SJK		
429	40	12/7/2005	SJK		
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SARA	ABUR	3 36/a	10	
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	DATE	EXMR
EAST: USPATS, USPGPUBS, USOCR, DERWENT, JPAB, EPAB	12/7/2005	SJK
eDAN Inventor Name Search	12/7/2005	SJK
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